Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/003,557	CHANG ET AL.	
Examiner	Art Unit	
Nhon T. Diep	2621	

SEARCHED					
Class	Subclass	Date	Examiner		
!					
			_		
			•		
	,				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	<u>!</u>			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East Search	2/3/07	N.D.		
		,		
,				